

Notice of References Cited

Application/Control No.

09/771,986

Applicant(s)/Patent Under

Reexamination

LEE ET AL.

Examiner

Yuwen Pan

Art Unit

2682

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,366,788	04-2002	Fujioka et al.	455/553.1
	B	US-			
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	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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